Data Sheet | January 2000 | File Number 2776.4

30A, 600V Ultrafast Diode

The RURP3060 is an ultrafast diode (t_{rr} < 55ns) with soft recovery characteristics. It has a low forward voltage drop and is of planar, silicon nitride passivated, ion-implanted, epitaxial construction.

This device is intended for use as an energy steering/ clamping diode and rectifier in a variety of switching power supplies and other power switching applications. Its low stored charge and ultrafast recovery with soft recovery characteristics minimize ringing and electrical noise in many power switching circuits, thus reducing power loss in the switching transistor.

Formerly developmental type TA09903.

Features

- Ultrafast with Soft Recovery . . . . . < 55ns
- Operating Temperature. . . . . 175^{o}C
- Reverse Voltage 600V
- Avalanche Energy Rated
- Planar Construction

Applications

- Switching Power Supply
- Power Switching Circuits
- General Purpose

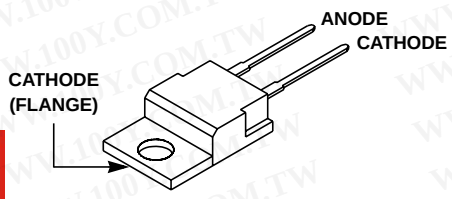
Ordering Information

PART NUMBER	PACKAGE	BRAND
RURP3060	TO-220AC	RURP3060

NOTE: When ordering, use the entire part number.

Packaging

JEDEC TO-220AC



Symbol

Absolute Maximum Ratings $T_C = 25^{o}C$, Unless Otherwise Specified

		RURP3060	UNITS
Peak Repetitive Reverse Voltage	V_{RRM}	600	V
Working Peak Reverse Voltage	V_{RWM}	600	V
DC Blocking Voltage	V_R	600	V
Average Rectified Forward Current ($T_C = 130^{o}C$)	$I_{F(AV)}$	30	A
Repetitive Peak Surge Current (Square Wave, 20kHz)	I_{FRM}	70	A
Nonrepetitive Peak Surge Current (Halfwave 1 Phase 60Hz)	I_{FSM}	325	A
Maximum Power Dissipation	P_D	125	W
Avalanche Energy (See Figures 7 and 8)	E_{AVL}	20	mJ
Operating and Storage Temperature	T_{STG}, T_J	-55 to 175	^{o}C

Electrical Specifications $T_C = 25^oC$, Unless Otherwise Specified

SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNITS
V_F	I_F = 30A	-	-	1.5	V
	I_F = 30A, $T_C = 150^oC$	-	-	1.3	V
I_R	V_R = 600V	-	-	250	µA
	V_R = 600V, $T_C = 150^oC$	-	-	1	mA
t_{rr}	I_F = 1A, dI_F/dt = 100A/µs	-	-	55	ns
	I_F = 30A, dI_F/dt = 100A/µs	-	-	60	ns
t_a	I_F = 30A, dI_F/dt = 100A/µs	-	30	-	ns
t_b	I_F = 30A, dI_F/dt = 100A/µs	-	20	-	ns
$R_{\theta JC}$		-	-	1.2	$^oC/W$

DEFINITIONS

V_F = Instantaneous forward voltage (pw = 300µs, D = 2%).

I_R = Instantaneous reverse current.

t_{rr} = Reverse recovery time at dI_F/dt = 100A/µs (See Figure 6), summation of $t_a + t_b$.

t_a = Time to reach peak reverse current at dI_F/dt = 100A/µs (See Figure 6).

t_b = Time from peak I_{RM} to projected zero crossing of I_{RM} based on a straight line from peak I_{RM} through 25% of I_{RM} (See Figure 6).

$R_{\theta JC}$ = Thermal resistance junction to case.

pw = Pulse width.

D = Duty cycle.

Typical Performance Curves

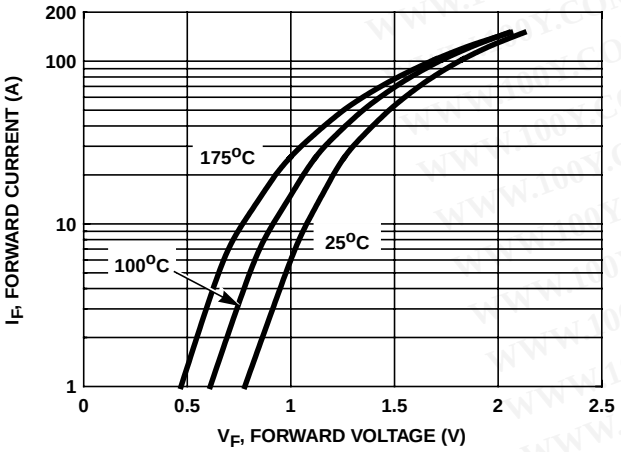


FIGURE 1. FORWARD CURRENT vs FORWARD VOLTAGE

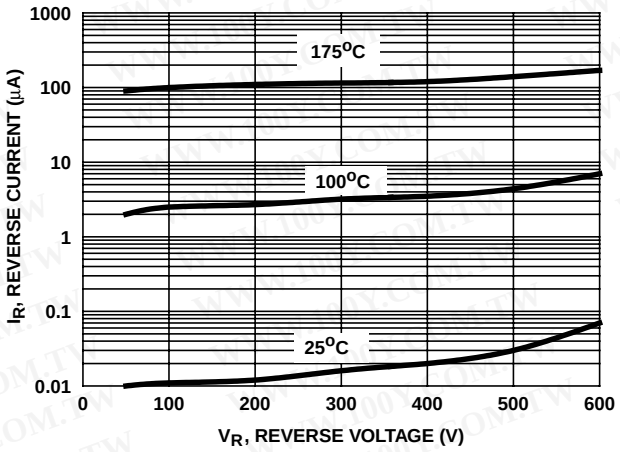


FIGURE 2. REVERSE CURRENT vs REVERSE VOLTAGE

Typical Performance Curves (Continued)

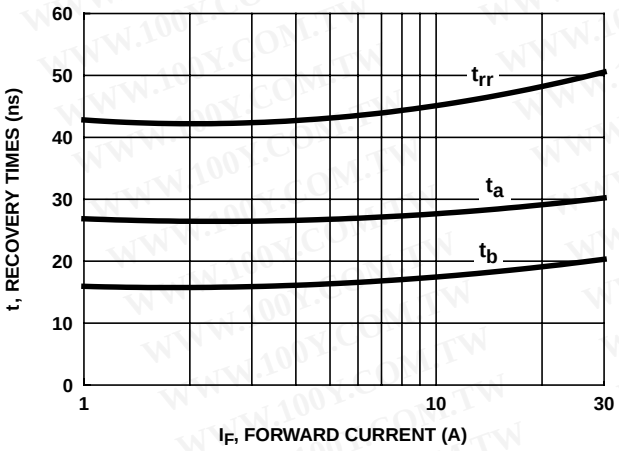


FIGURE 3. t_{rr}, t_a AND t_b CURVES vs FORWARD CURRENT

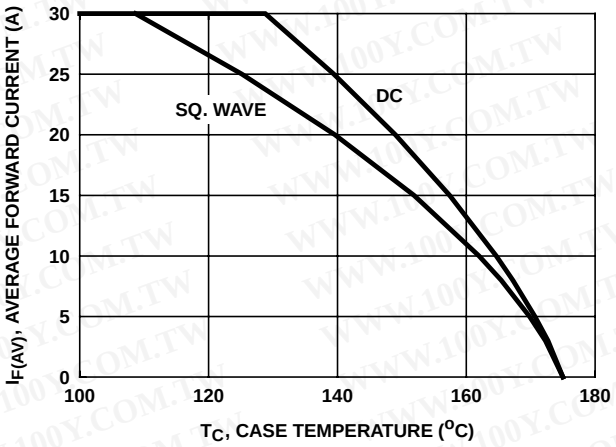


FIGURE 4. CURRENT DERATING CURVE

Test Circuits and Waveforms

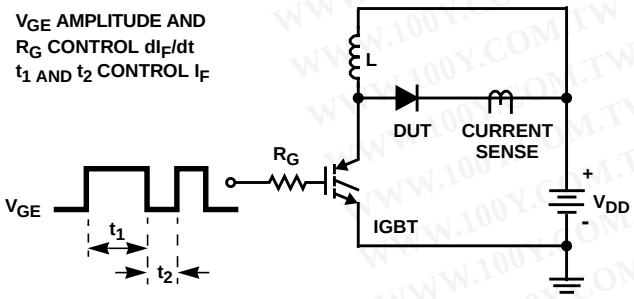


FIGURE 5. t_{rr} TEST CIRCUIT

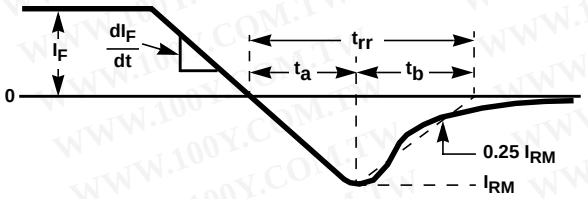


FIGURE 6. t_{rr} WAVEFORMS AND DEFINITIONS

I = 1A
L = 40mH
R < 0.1Ω
$E_{AVL} = 1/2LI^2 [V_{R(AVL)}/(V_{R(AVL)} - V_{DD})]$
Q_1 = IGBT (BV_{CES} > DUT $V_{R(AVL)}$)

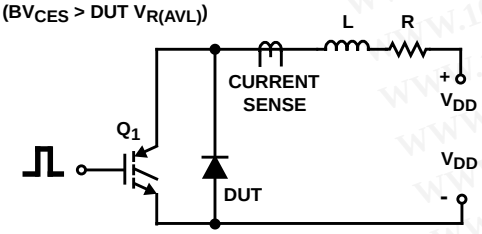


FIGURE 7. AVALANCHE ENERGY TEST CIRCUIT

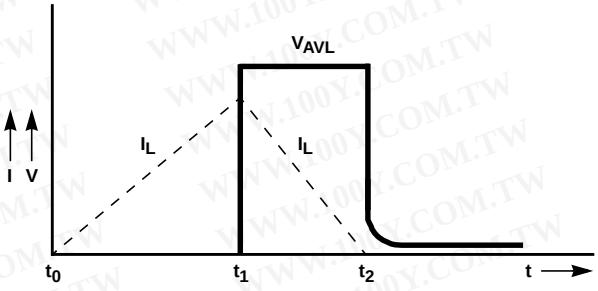


FIGURE 8. AVALANCHE CURRENT AND VOLTAGE WAVEFORMS